052N03S-VB QFN8(5X6) Datasheet N-Channel 30 V (D-S) MOSFET

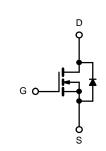
PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ.)	
30	0.003 at V _{GS} = 10 V	120	71 nC	
	0.005 at V _{GS} = 4.5 V	90	71110	

FEATURES

- Trench Power MOSFET
- 100 % R_g and UIS Tested

APPLICATIONS

- Notebook PC Core
- VRM/POL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S (T _A = 25 °C, unle	ss otherwise not	ed)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}		V
Gate-Source Voltage		V _{GS}		v
	T _C = 25 °C	°C I _D	120 ^{a, e}	
Continuous Drain Current (T ₁ = 175 °C)	T _C = 70 °C		90 ^e	
	T _A = 25 °C		21 ^{b, c}	А
	T _A = 70 °C		20.8 ^{b, c}	~
Pulsed Drain Current		I _{DM}	250	
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	56	
		Е		

Notes:

- a. Based on $T_C = 25$ °C. b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.

d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature. Package limitation current is 80 A.

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Y UBsemi www.VBsemi.com			

Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static	Cymbol			Typ.	max.	onic	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 µA	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	1.0		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
-	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1		
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, V_{GS} = 10 V	80			Α	
		V _{GS} = 10 V, I _D = 32 A		0.003		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 29 A		0.005			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 32 A		130		S	
Dynamic ^b							
Input Capacitance	C _{iss}				3200	pF	
Output Capacitance	C _{oss}	V_{DS} = 12.5 V, V_{GS} = 0 V, f = 1 MHz			1025		
Reverse Transfer Capacitance	C _{rss}				970		
Total Gate Charge	Q _g	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 32 \text{ A}$			71	nC	
					61.5		
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 29 A			34		
Gate-Drain Charge	Q _{gd}				29		
Gate Resistance	R _g	f = 1 MHz		1.4	2.1	Ω	
Turn-On Delay Time	t _{d(on)}			18	27	- ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.555 Ω		11	17		
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong$ 27 A, V_{GEN} = 10 V, R_{g} = 1 Ω		70	105		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			55	83		
Rise Time	t _r	V_DD = 15 V, R_L = 0.625 Ω		180	270		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D} \cong$ 24 A, V_GEN = 4.5 V, R_g = 1 Ω		55	83		
Fall Time	t _f			12	18		
Drain-Source Body Diode Characteristic	s		1		1		
Continuous Source-Drain Diode Current	۱ _S	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$			80	A	
Pulse Diode Forward Current ^a	I _{SM}				100		
Body Diode Voltage	V _{SD}	I _S = 22 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		70.2	105	nC	
Reverse Recovery Fall Time	t _a	$r_{\rm F} = 20$ A, $a_{\rm F}a_{\rm F} = 100$ A/ $\mu_{\rm S}$, $r_{\rm J} = 20$ C		27		200	
Reverse Recovery Rise Time	t _b			25		ns	

Notes:

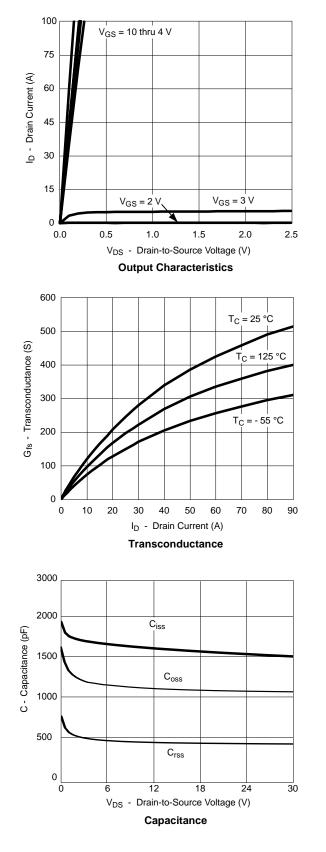
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

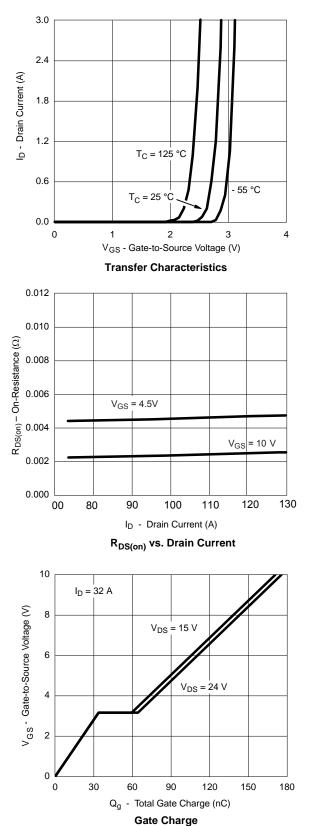
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



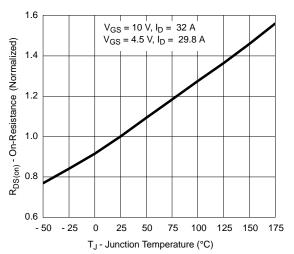
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



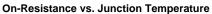


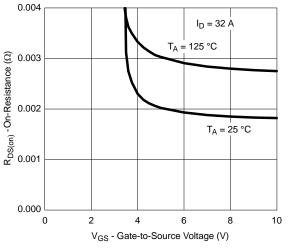
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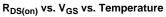




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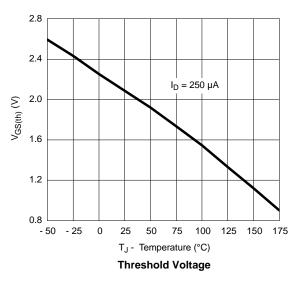


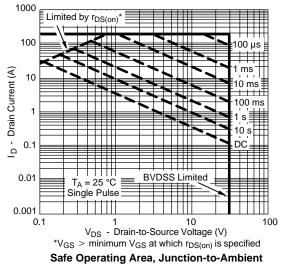




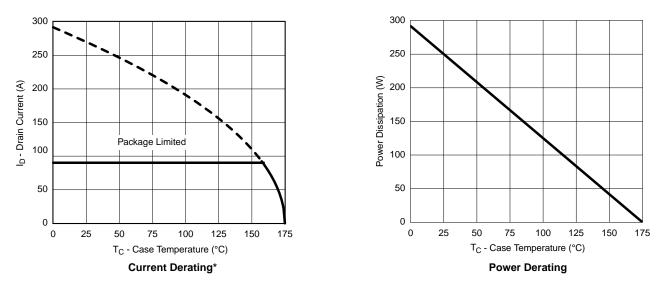


Forward Diode Voltage vs. Temperature



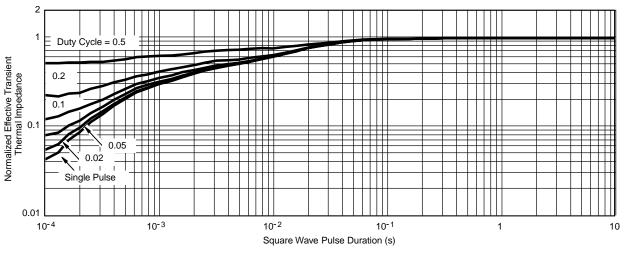




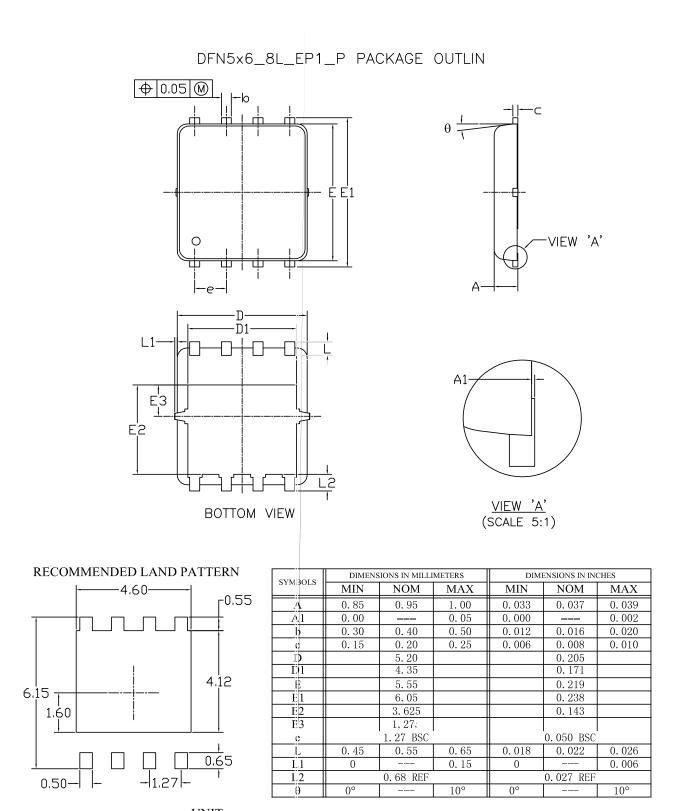


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

* The power dissipation P_D is based on $T_{J(max)} = 175 \text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case



NOTE

UNIT: mm

 PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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